

# • General Description

The AGM310MD combines advanced trench MOSFET technology with a low resistance package to provide extremely low  $R_{\text{DS(ON)}}$ .

This device is ideal for load switch and battery protection applications.

#### Features

- Advance high cell density Trench technology
- Low R<sub>DS(ON)</sub> to minimize conductive loss
- ■Low Gate Charge for fast switching
- ■Low Thermal resistance
- ■100% Avalanche tested
- ■100% DVDS tested

#### Application

- ■MB/VGA Vcore
- ■SMPS 2<sup>nd</sup> Synchronous Rectifier
- ■POL application
- ■BLDC Motor driver

# **Product Summary**

BVDSS	RDSON	ID
30V	11mΩ	23A
-30V	22mΩ	-18A

# TO-252-4L Pin Configuration



# **Package Marking and Ordering Information**

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
AGM310MD	AGM310MD	TO-252-4L	330mm	16mm	2500

### Table 1. Absolute Maximum Ratings (TA=25°C)

		Rating		
Symbol	Parameter	N-Ch	P-Ch	Units
V <sub>DS</sub>	Drain-Source Voltage (V <sub>GS</sub> =0V)	30	-30	V
V <sub>GS</sub>	Gate-Source Voltage (V <sub>DS=</sub> 0V)	±20	±20	V
	Drain Current-Continuous(Tc=25°C) (Note 1)	23	-18	А
l <sub>D</sub>	Drain Current-Continuous(Tc=100°C)	15	-14	А
IDM (pluse)	Drain Current-Pulsed (Note 2)	92	-72	Α
	Total Power Dissipation(Tc=25℃)	37	37	W
P₀	Total Power Dissipation(TA=100°C)	15	15	W
EAS	Avalanche energy (Note 3)	34	39	mJ
TJ,TSTG	Operating Junction and Storage Temperature Range	-55 To 150	-55 To 150	°C

Table 2. Thermal Characteristic

Symbol	Parameter	Тур	Max	Unit
$R_{ heta JA}$	Thermal Resistance Junction-ambient (Steady State) <sup>1</sup>		50	°C/W
R <sub>θ</sub> JC	Thermal Resistance Junction-Case <sup>1</sup>		3.4	°C/W



Table 3. N- Channel Electrical Characteristics (Tj=25℃unless otherwisenoted)

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
On/Off State	es					
BVDSS	Drain-Source Breakdown Voltage	VGS=0V ID=250μA	30			V
IDSS	Zero Gate Voltage Drain Current	VDS=30V,VGS=0V			1	μΑ
IGSS	Gate-Body Leakage Current	VGS=±20V,VDS=0V			±100	nA
VGS(th)	Gate Threshold Voltage	VDS=VGS,ID=250μA	1.2	1.6	2.2	V
gFS	Forward Transconductance	VDS=5V,ID=10A		10		S
RDS(on)	Drain-Source On-State Resistance	VGS=10V, ID=20A		11	17	mΩ
T DO(OII)	Brain course on class recipiante	VGS=4.5V, ID=10A		17	25	mΩ
Dynamic C	Characteristics					
Ciss	Input Capacitance			610		pF
Coss	Output Capacitance	VDS=15V,VGS=0V,		105		pF
Crss	Reverse Transfer Capacitance	F=1MHZ		92		pF
Rg	Gate resistance	VGS=0V, VDS=0V,f=1.0MHz		2.1		Ω
Switching	Times					
td(on)	Turn-on Delay Time			4.7		nS
tr	Turn-on Rise Time	VGS=10V,VDS=15V,		11		nS
td(off)	Turn-Off Delay Time	RL=0.75Ω,RGEN=3.3Ω		17		nS
tf	Turn-Off Fall Time			5.6		nS
Qg	Total Gate Charge			16		nC
Qgs	Gate-Source Charge	VGS=10V, VDS=15V, ID=10A		3.0		nC
Qgd	Gate-Drain Charge	_ ID-10A		3.8		nC
Source-Dr	ain Diode Characteristics	1	1			
ISD	Source-Drain Current(Body Diode)				23	Α
VSD	Forward on Voltage	VGS=0V,IS=20A			1.2	V
trr	Reverse Recovery Time	IF=20A , dI/dt=100A/μs ,				ns
Qrr	Reverse Recovery Charge	TJ=25℃				nc

Notes 1. The maximum current rating is package limited.

Notes 2.Repetitive Rating: Pulse width limited by maximum junction temperature Notes 3

.EAS condition: TJ=25  $^{\circ}\text{C}$  ,VDD=20V,Vgs=10V,ID=26A, L=0.1mH,RG=25ohm



Table 3. P-Channel Electrical Characteristics (Tj=25℃unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
On/Off Sta	tes					
BVDSS	Drain-Source Breakdown Voltage	VGS=0V ID=-250µA	-30			V
IDSS	Zero Gate Voltage Drain Current	VDS=-24V,VGS=0V			-1	μA
IGSS	Gate-Body Leakage Current	VGS=±20V,VDS=0V			±100	nA
VGS(th)	Gate Threshold Voltage	VDS=VGS,ID=-250µA	-1.2	-1.7	-2.2	V
gFS	Forward Transconductance	VDS=-5V,ID=-10A		30		S
RDS(on)	Drain-Source On-State Resistance	VGS=-10V, ID=-20A		22	30.1	mΩ
1100(011)	Diam course on clate recipiante	VGS=-4.5V, ID=-10A		28	36	mΩ
Dynamic C	Characteristics					
Ciss	Input Capacitance	VDS=-15V,VGS=0V,		745		pF
Coss	Output Capacitance	F=1MHZ		113		pF
Crss	Reverse Transfer Capacitance			99		pF
Rg	Gate resistance	VGS=0V, VDS=0V,f=1.0MHz		9.5		Ω
Switching	Times					
td(on)	Turn-on Delay Time			8		nS
tr	Turn-on Rise Time	VGS=-10V,VDS=-15V,		18		nS
td(off)	Turn-Off Delay Time	ID=-15A,RGEN=3.3Ω		31.8		nS
tf	Turn-Off Fall Time			18.4		nS
Qg	Total Gate Charge			12		nC
Qgs	Gate-Source Charge	VGS=-10V, VDS=-25V, ID=-12A		2.0		nC
Qgd	Gate-Drain Charge	VD323V, ID12A		2.9		nC
Source-Dra	ain Diode Characteristics		•	'		1
ISD	Source-Drain Current(Body Diode)				-18	Α
VSD	Forward on Voltage	VGS=0V,IS=-20A			-1.2	V
trr	Reverse Recovery Time	IF=-20A , dI/dt=100A/μs ,				ns
Qrr	Reverse Recovery Charge	TJ=25℃				nc

Notes 1. The maximum current rating is package limited.

Notes 2. Repetitive Rating: Pulse width limited by maximum junction temperature Notes

3.EAS condition: TJ=25 $^{\circ}$ C,VDD=-20V,Vgs=-10V,ID=-28A, L=0.1mH,RG=25ohm



#### •N Channel characteristics curve

Fig.1 Power Dissipation Derating Curve

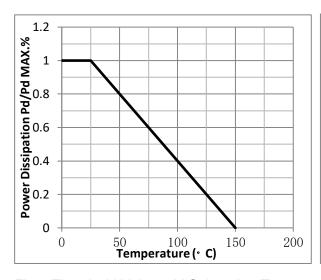


Fig.2 Typical output Characteristics

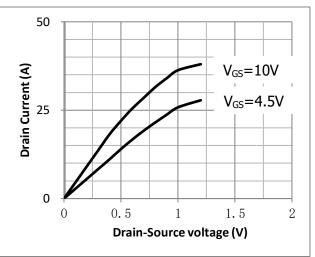


Fig.3 Threshold Voltage V.S Junction Temperature

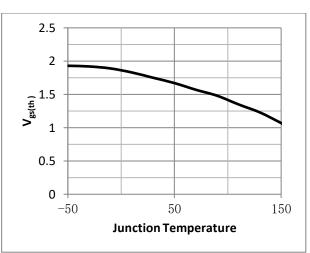


Fig.4 Resistance V.S Drain Current

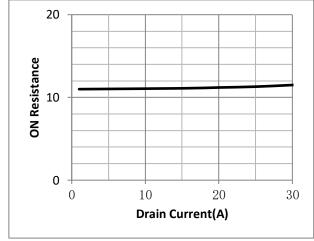


Fig.5 On-Resistance VS Gate Source Voltage

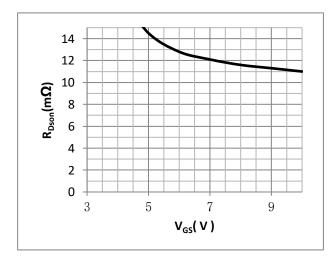
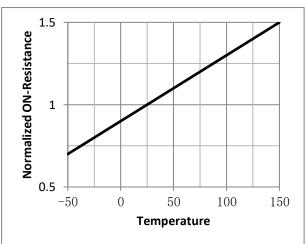


Fig.6 On-Resistance V.S Junction Temperature





### •P Channel characteristics curve

Fig.1 Power Dissipation Derating Curve

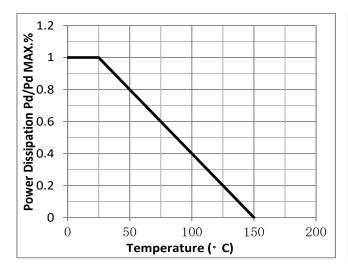


Fig.2 Typical output Characteristics

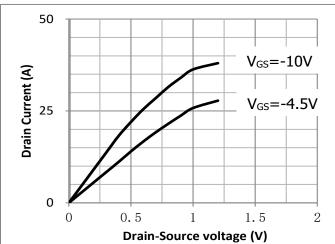
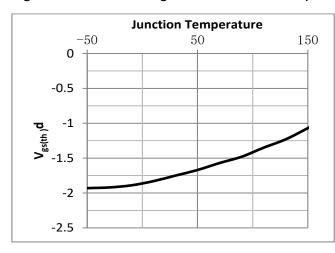


Fig.3 Threshold Voltage V.S Junction Temperature

Fig.4 Resistance V.S Drain Current



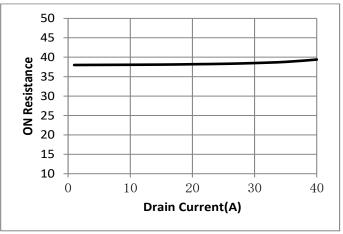


Fig.5 On-Resistance VS Gate Source Voltage

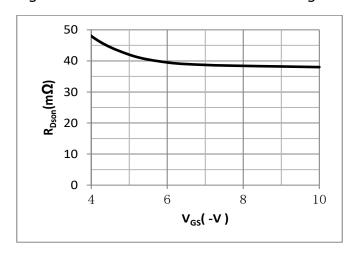
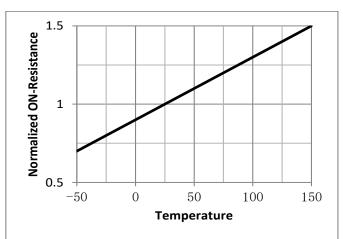


Fig.6 On-Resistance V.S Junction Temperature





#### Test Circuit

Fig.1 Switching Time Measurement Circuit

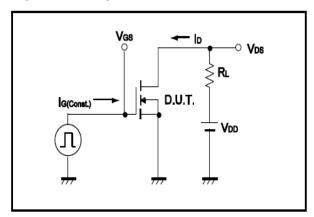


Fig.2 Gate Charge Waveform

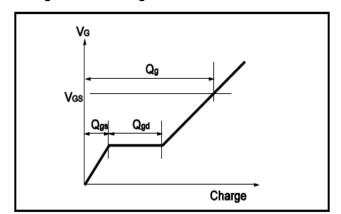


Fig.3 Switching Time Measurement Circuit

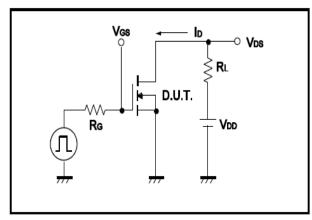


Fig.4 Gate Charge Waveform

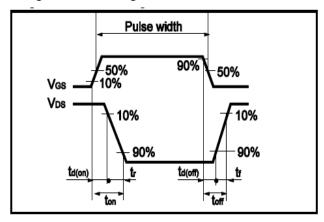


Fig.5 Avalanche Measurement Circuit

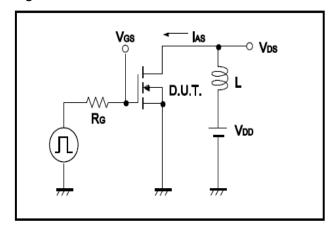
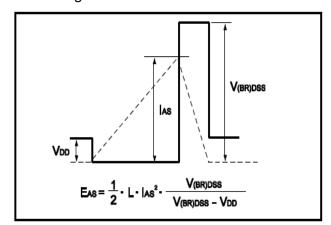
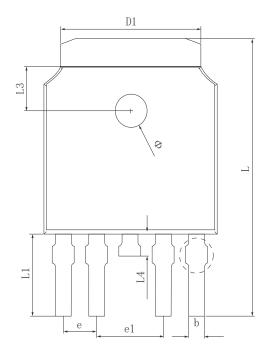


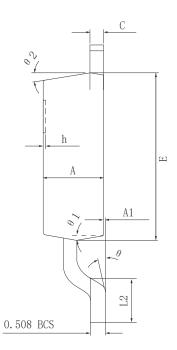
Fig.6 Avalanche Waveform

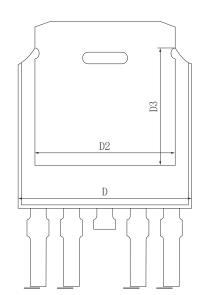


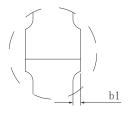


# •Dimensions (TO-252-4L)





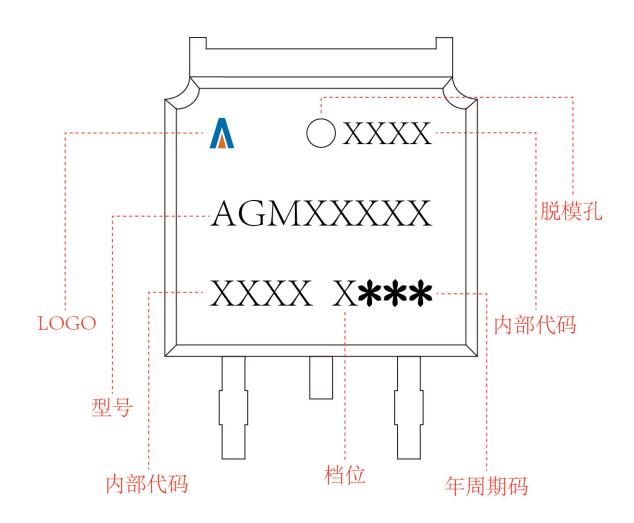




GUARDOI	MILLIMETER			
SYMBOL	MIN	Typ.	MAX	
A	2. 200	2. 300.	2.400	
A1	0.000		0. 127	
b	0.550	0.600	0.650	
b1	0.000		0.120	
c(电镀后)	0.460	0. 520	0.580	
D	6.500	6. 600	6. 700	
D1	5. 334 REF			
D2	5.346 REF			
D3	4.490 REF			
E	6.000	6. 100	6. 200	
е	1.270 TYP			
e1	2.540 TYP			
h	0.000	0.100	0. 200	
L	9.900	10. 100	10. 300	
L1		2.988 REF		
L2	1.400	1.550	1.700	
L3	1.600 REF			
L4	0.700	0.800	0.900	
Φ	1.100	1. 200	1. 300	
θ	0°		8°	
θ 1		9° TYP		
θ2	9° TYP			



TO-252-4L Marking Instructions:





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